

N-Channel Logic Level Enhancement Mode Power MOSFET

Description

The MSD2N60 is a N-channel enhancement-mode MOSFET , providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-252 package is universally preferred for all commercial-industrial applications

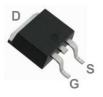
Features

- · Originative New Design
- · Very Low Intrinsic Capacitances
- · Excellent Switching Characteristics
- Unrivalled Gate Charge : 9.5nC (Typ.)
- Extended Safe Operating Area
- Lower RDS(ON) : 4.0 Ω (Typ.) @VGS=10V
- 100% Avalanche Tested
- RoHS compliant package

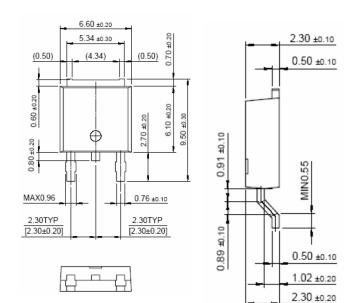
Packing & Order Information

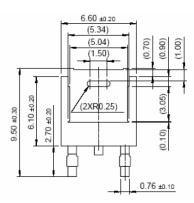
Part No./ T : 2,500/Reel

Part No./ R : 80/Tube , 4,000/Box

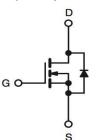








Graphic symbol



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value	Unit			
V _{DSS}	Drain-Source Voltage	600	V			
V _{GS}	Gate-Source Voltage	±30	V			
I _D	Continuous Drain Current @ TC=25°C	2	A			
	Continuous Drain Current @ TC=100°C	1.3	A			



N-Channel Logic Level Enhancement Mode Power MOSFET

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)						
Symbol	Parameter	Value	Unit			
I _{DM}	Pulsed Drain Current	8.0	A			
dv/dt	Peak Diode Recovery dv/dt	4.5	V/ns			
E _{AS}	Single Pulsed Avalanche Energy	120	mJ			
E _{AR}	Repetitive Avalanche Energy	5.4	mJ			
Р	Power Dissipation (TC=25°C)	23	W			
P _D	- Derate above 25°C	0.18	W			
TJ/T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C			
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300				

· Drain current limited by maximum junction temperature

Thermal Resistance Characteristics					
Symbol	Parameter	Maximum	Units		
R _{θJ} c	Junction-to-Case	2.87	°C/W		
$R_{ extsf{ heta}JA}$	Junction-to-Ambient	50	C/VV		

On Characteristics					
Symbol	Test Conditions	Min	Тур.	Max.	Units
V _{GS}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0		4.0	V
R _{DS(ON)}	$V_{GS} = 10 \text{ V}$, $I_D = 3.5 \text{ A}$		40	47	Ω

Off Characteristics					
Symbol	Test Conditions	Min	Тур.	Max.	Units
BV _{DSS}	$V_{GS}{=}0$ V , $I_{D}{=}250~\mu A$	600			V
$\Delta BV_{DSS} / \Delta T_{J}$	$I_D = 250\mu A$, Referenced to $25^{\circ}C$		0.6		V/°C
	$V_{\text{DS}}{=}600$ V , $V_{\text{GS}}{=}0$ V			10	μA
I _{DSS}	$V_{DS} = 480 \text{ V}$, $T_{C} = 125^{\circ}\text{C}$			100	
I _{GSSF}	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA

Dynamic Characteristics						
Symbol	Test Conditions	Min	Тур.	Max.	Units	
C _{ISS}			320	420	pF	
C _{OSS}	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ = F = 1.0MHz		35	46	pF	
C _{RSS}			4.5	6.0	pF	



N-Channel Logic Level Enhancement Mode Power MOSFET

Switching Characteristics					
Symbol	Test Conditions	Min	Тур.	Max.	Units
t _{d(on)}			8	30	ns
t _r	$V_{DS} = 300 \text{ V}, \text{ I}_{D} = 2 \text{ A},$		23	60	ns
t _{d(off)}	$R_G = 25 \Omega$		25	60	ns
tf			28	70	ns
Qg			9.5	13	nC
Q _{gs}	$V_{DS} = -480 \text{ V}, \text{ I}_{D} = 2 \text{ A},$ $V_{GS} = 10 \text{ V}$		1.6		nC
Q _{gd}	VGS - 10 V		4.0		nC

Source-Drain Diode Maximum Ratings and Characteristics					
Symbol	Test Conditions	Min	Тур.	Max.	Units
I _S				2.0	A
I _{SM}				6.0	A
V _{SD}	$I_S = 2 A$, $V_{GS} = 0 V$			1.4	V
t _{rr}			230		ns
Q _{rr}	$I_{\rm S}$ = 2 A , $V_{\rm GS}$ = 0 V , dIF/dt=100A/µs		1.0		nC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature

2. I_{AS} =2.0A, V_{DD} =50V, R_{G} =25 Ω , Starting TJ =25°C

3. I_{SD}≤2.0A, di/dt≤300A/µs, VDD≤BVDSS , Starting TJ =25 °C

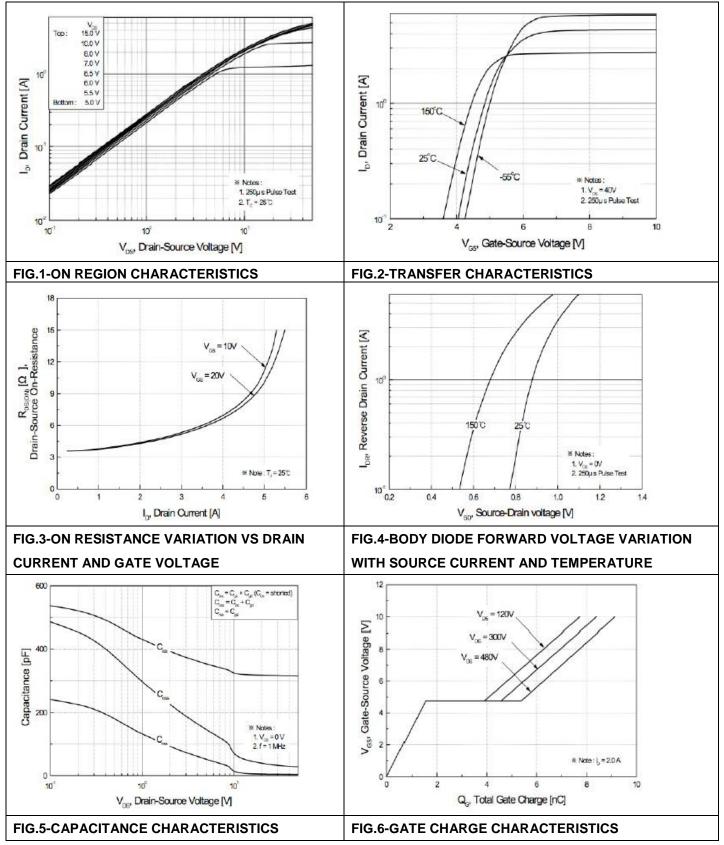
4. Pulse Test : Pulse Width ≤ 300µs, Duty Cycle ≤ 2%

5. Essentially Independent of Operating Temperature



N-Channel Logic Level Enhancement Mode Power MOSFET

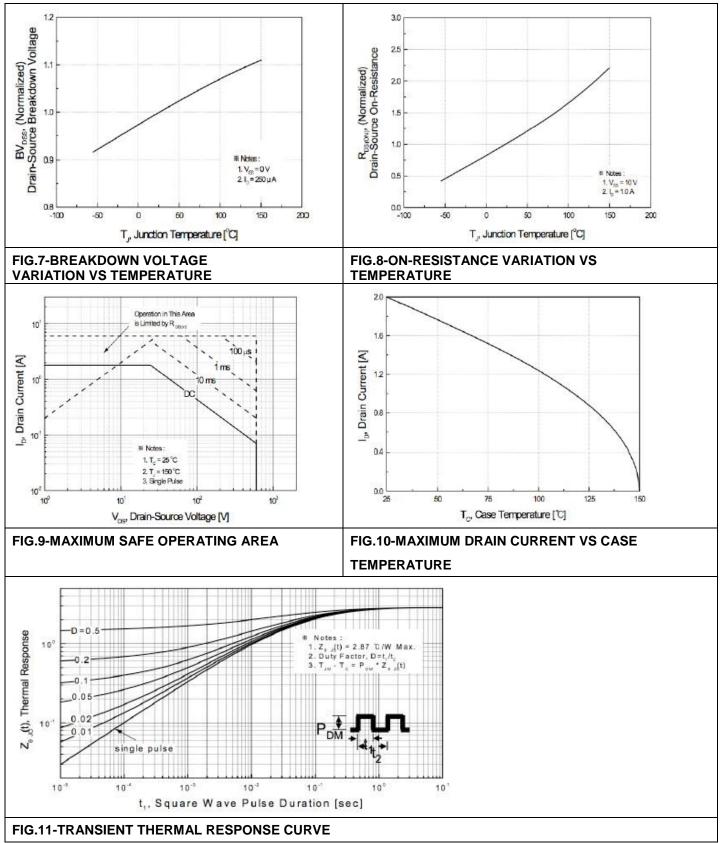
Characteristics Curve





N-Channel Logic Level Enhancement Mode Power MOSFET

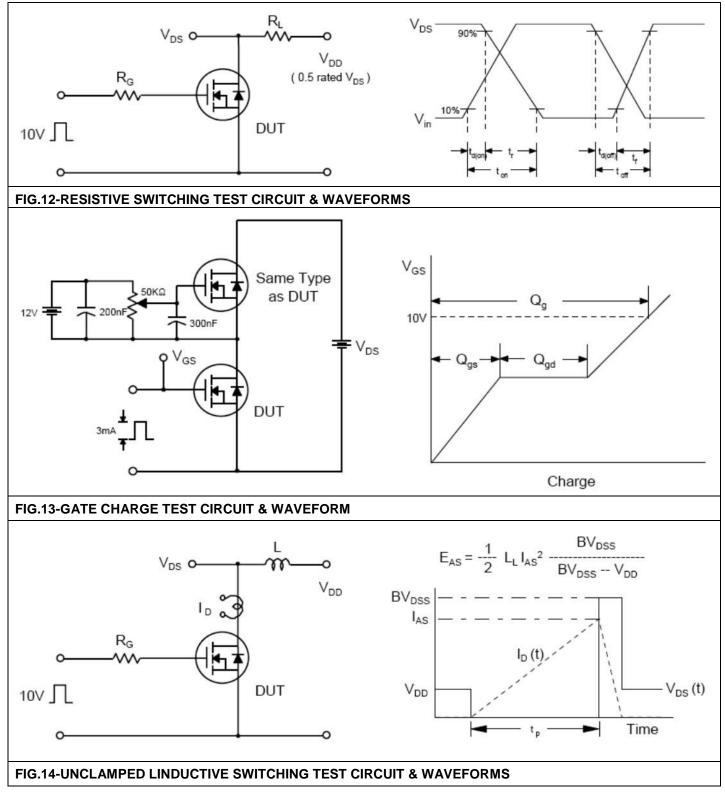
Characteristics Curve





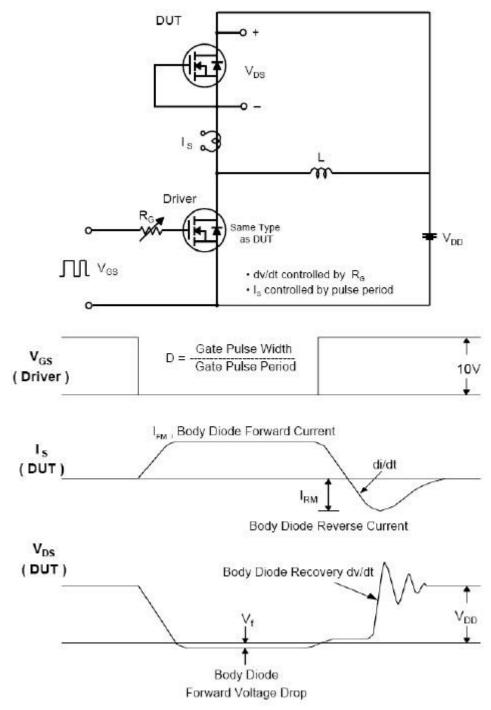
N-Channel Logic Level Enhancement Mode Power MOSFET

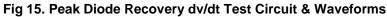
Characteristics Test Circuit & Waveform





N-Channel Logic Level Enhancement Mode Power MOSFET







N-Channel Logic Level Enhancement Mode Power MOSFET

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE. Bruckewell Technology Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Bruckewell"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product. Bruckewell makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Bruckewell disclaims

- (i) Any and all liability arising out of the application or use of any product.
- (ii) Any and all liability, including without limitation special, consequential or incidental damages.

(iii) Any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Bruckewell's knowledge of typical requirements that are often placed on Bruckewell products in generic applications.

Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and/or specifications may vary in different applications and performance may vary over time.

Product specifications do not expand or otherwise modify Bruckewell's terms and conditions of purchase, including but not limited to the warranty expressed therein.